


<b>Search Notes</b>  	<b>Application/Control No.</b>  10500210	<b>Applicant(s)/Patent Under Reexamination</b>  YAMASHITA ET AL.
	<b>Examiner</b>  WEN-YING P CHEN	<b>Art Unit</b>  2871

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
reviewed previously cited references	7/16/2008	wpc
consulted primary examiner Andrew Schechter regarding the submitted affidavit	7/16/2008	wpc
349/114 combined with key words search of all databases in EAST	1/4/2009	wpc
key words search of claims in 349/114	1/4/2009	wpc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
	see enclosed EAST search history	1/4/2009	wpc

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